

\* PATENT APPLICATION  
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FORM PTO-1449

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ATTY. DKT NO.	01-598	SER. NO.	10/829,255
APPLICANT	TOTANI et al.		
FILING DATE	April 22, 2004	GROUP	3729

# REFERENCE DESIGNATION

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
RC	6,449,836 B1 (Corresponds to JP-A-2001-111209 and JP-A-2001-223465)	9/17/02	MIYAKE et al.		
RC	6,784,375 B2 (Corresponds to JP-A-2001-111209 and JP-A-2001-223465)	8/31/04	MIYAKE et al.		

## FOREIGN PATENT DOCUMENTS

### TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
								Eng. Abstract	
RC	JP-A-2000-021930	1/21/00	JAPAN					X	

\* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

Notice of Reason for Refusal from Japanese Patent Office issued on May 30, 2006 for the corresponding Japanese patent application No. 2003-124271 (a copy and English translation thereof)		DATE CONSIDERED	12/05/2006
EXAMINER	/Rick Chang/		

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
RC		US 2003/0079341 A1	May 1, 2003	Miyake et al.		

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	TRANSLATION	
									NO	Eng. Abstract
RC		JP-A-10-270820 (Discussed on page 2 of the spec.)	10/9/98	JAPAN						X

\* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

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